

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

n re Patent Application of) MAIL STOP RCE
Megumi TAKEMOTO et al.) Group Art Unit: 2829
Application No.: 10/645,595) Examiner: Vinh P. NGUYEN
Filed: August 22, 2003) Confirmation No.: 9467
For: SEMICONDUCTOR DEVICE TEST PROBE HAVING IMPROVED TIP PORTION))))

FOURTH INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure as set forth in 37 C.F.R. § 1.56, the accompanying information is being submitted in accordance with 37 C.F.R. §§ 1.97 and 1.98.

Pursuant to 37 C.F.R. § 1.98, a copy of each of the documents cited is enclosed.

The information is being submitted before the mailing of a first Office Action after the filing of a Request for Continued Examination under 37 C.F.R. § 1.114. Continued examination is requested and the fee required under 37 C.F.R. § 1.17(e) accompanies the present submission.

Attached for the Examiner's consideration is a partial translation of each non-English document cited in the attached form PTO-1449. Also attached for the Examiner's consideration is an abstract of each of the cited Japanese patent documents.

To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner initialed copy of this form be returned to the undersigned.

FOURTH Information Disclosure Statement Application No. <u>10/645,595</u> Attorney's Docket No. <u>1025260-000091</u> Page 2

The Director is hereby authorized to charge any appropriate fees under 37 C.F.R. § 1.16, 1.17 and 1.21 that may be required by this paper, and to credit any overpayment, to Deposit Account No. 02-4800. This paper is submitted in duplicate.

Respectfully submitted,

BUCHANAN INGERSOLL & ROONEY PC

Date: February 14, 2007

By: Pager H

Registration No. 46317

P.O. Box 1404 Alexandria, VA 22313-1404 703 836 6620

Examiner Initials	Document Kind Code (if known)			Name of Patentee or Applicant of Cited Document							licatio D-YY	n Date YY)
			FORE	GN PATENT DOC	UMENTS							
Examiner Initials	Document Number	Kind Code (if known)		Country	Date of Publication (MM-DD-YYYY)	Translation	Partial Translation	Eng. Lang. Summary	Report	IPER	Abstract	Cited in Spec
	6-61316		JAPAN	J .	03-04-1994		X			<u> </u>	Х	
	7-63785		JAPAI	J	03-10-1995		Х				Х	
	8-152436		JAPAN	V	06-11-1996		X				X	
		NON	-PATE	NT LITERATURE	DOCUMENTS							
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Examiner				Date								

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609. Draw line through citation if not in

conformance and not considered. Include copy of this form with next communication to Applicant.

Application Number

First Named Inventor

Attorney Docket No.

U.S. PATENT DOCUMENTS

Examiner Name

Filing Date

Complete if Known

August 22, 2003

Vinh P. NGUYEN

1025260-000091

Megumi TAKEMOTO et al.

10/645,595

Substitute for form 1449/PTO & 1449B/PTO

Sheet

FOURTH

INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

(use as many sheets as necessary